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**ELECTRICAL MEASUREMENTS AND
ANALOGUE ELECTRONICS I**

Oct./Nov. 2023

Time: 3 hours



THE KENYA NATIONAL EXAMINATIONS COUNCIL

**DIPLOMA IN ELECTRICAL AND ELECTRONIC ENGINEERING
(POWER OPTION)
(TELECOMMUNICATION OPTION)
(INSTRUMENTATION OPTION)**

MODULE I

ELECTRICAL MEASUREMENTS AND ANALOGUE ELECTRONICS I

3 hours

INSTRUCTIONS TO CANDIDATES

You should have the following for this examination.

Answer booklet;

Mathematical table/Non-programmable electronic calculator;

Drawing instruments.

The paper consists of EIGHT questions in TWO sections; A and B.

Answer THREE questions from section A and TWO questions from section B in the answer booklet provided.

All questions carry equal marks.

Maximum marks for each part of the question are as indicated.

Candidates should answer the questions in English.

Take: Electron charge, $e = 1.602 \times 10^{-19} \text{ C}$;

Electron mass, $m = 9.109 \times 10^{-31} \text{ kg}$.

This paper consists of 6 printed pages.

**Candidates should check the question paper to ascertain that
all the pages are printed as indicated and that no questions are missing.**

SECTION A: ELECTRICAL MEASUREMENTS

Answer **THREE** questions from this section.

1. (a) (i) State the physical quantities whose units are classified as primary fundamental units.
(ii) Describe secondary standards with respect to measurements. (7 marks)
- (b) Derive, from first principles, the dimensional equation for electromotive force (e.m.f) in c.g.s. electromagnetic units. (10 marks)
- (c) State the derived units for each of the following quantities:
(i) magnetic flux density;
(ii) angular acceleration;
(iii) density. (3 marks)
2. (a) (i) State **three** factors that can introduce errors in power measurements when using wattmeters;
(ii) With aid of a phasor diagram, show that the two-wattmeter method of power measurement gives the total power in a 3-phase balanced load. (12 marks)
- (b) (i) With aid of a labelled diagram, explain the measurement of magnetic flux density using the hall effect;
(ii) Sketch and label the B-H curve of a magnetic material. (8 marks)
3. (a) State **four** merits of a circuit diagram as a fault finding aid. (4 marks)

- (b) Figure 1 shows a diagram of a d.c motor speed control system. A fault occurs that results in the loss of the feedback voltage.
- State **three** possible causes of the fault;
 - Explain the effect of the fault on the speed of the motor. (6 marks)

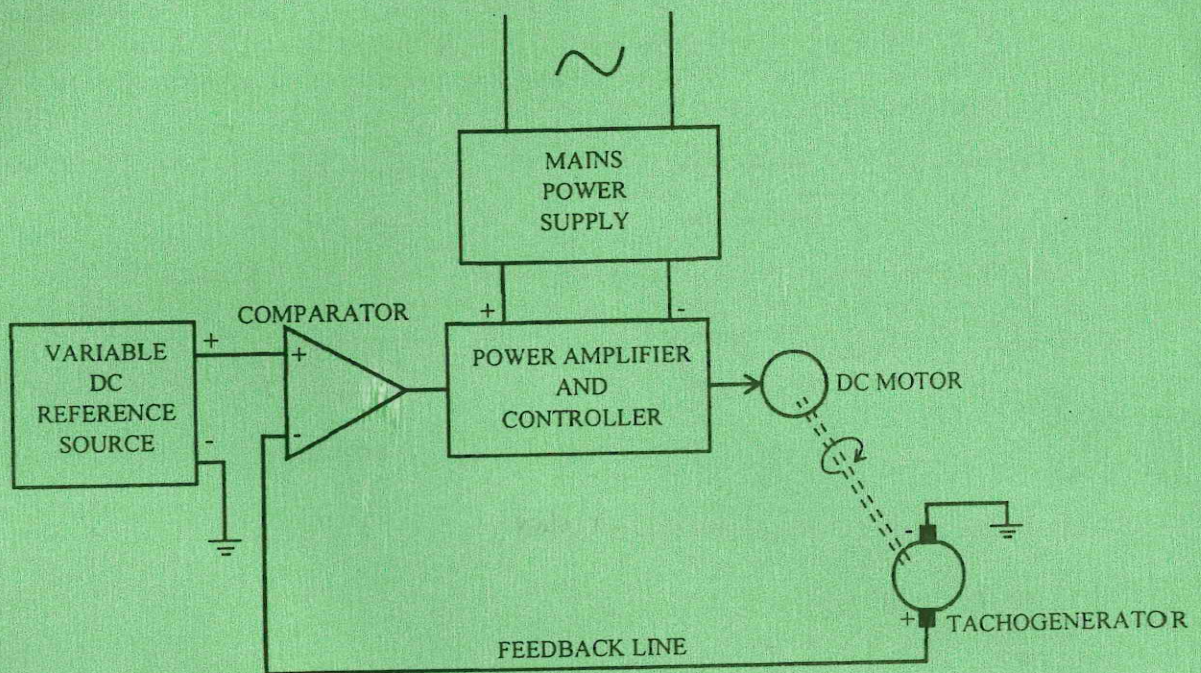


Fig. 1

- Outline the procedure of soldering a component on to a printed circuit board. (6 marks)
 - Explain the function of each of the following test equipment used in logic circuits:
 - logic state monitor;
 - logic probe. (4 marks)
4. (a) (i) Distinguish between quality and reliability of an engineering system.
- Explain each of the following with respect to reliability:
 - mean time between failure (MTBF).
 - mean time to fail (MTTF). (6 marks)

- (b) State:
- two causes of failure in an engineering system;
 - two methods used to minimize failures due to high temperatures. (4 marks)
- (c) Figure 2 shows a block diagram arrangement of various components in an equipment. The MTBFs for the components are: A = 30,000 hours, B = 60,000 hours, C = 100,000 hours and D = 75,000 hours. Determine the reliability of the equipment for an operating period of 1,000 hours. (10 marks)

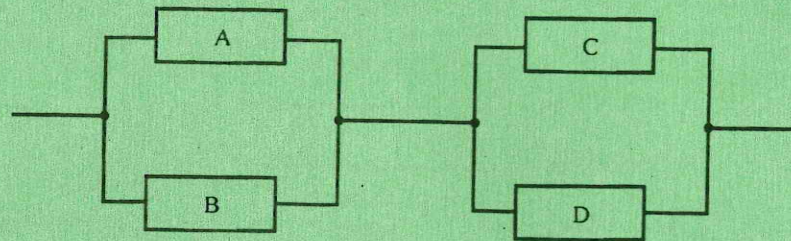


Fig. 2

5. (a) Describe each of the following phases of corrective maintenance:
- fault detection;
 - fault location. (4 marks)
- (b) Figure 3 shows a schematic block diagram of a regulated d.c power supply. Draw a flow chart for troubleshooting the power supply. (8 marks)

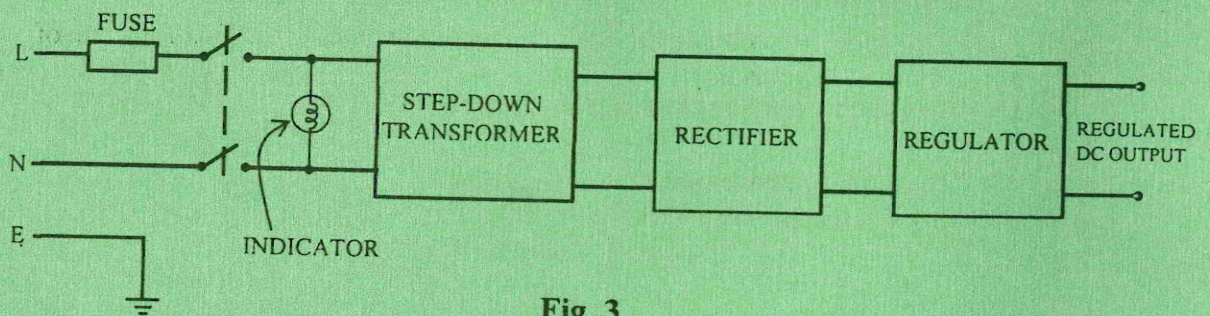


Fig. 3

- (c) The repair rate of a large generator, which has a mean time between failure of 58,000 hours, is 6.25% per hour. Determine the following for the generator:
- mean time to repair;
 - maintainability for an operating period of 24 hours.
 - availability;
 - unavailability due to breakdown. (8 marks)

SECTION B: ANALOGUE ELECTRONICS I

Answer **TWO** questions from this section.

6. (a) With respect to atomic theory, state:
- (i) **two** Bohr's postulates;
 - (ii) **one** Plank's quantum theory. (3 marks)
- (b) With aid of a labelled diagram, describe the formation a of depletion layer in p-n junction. (7 marks)
- (c) The base-emitter voltage of a transistor connected in common-emitter configuration varies from 0.8V to 2.5V . This causes a corresponding variation of base current from $20\ \mu\text{A}$ to $50\ \mu\text{A}$ and collector current from 1.6mA to 4.6mA. Assuming linear operation, determine the:
- (i) input resistance, r_i ;
 - (ii) d.c current gain, β ;
 - (iii) equivalent common-base d.c current gain, α . (6 marks)
- (d) Explain each of the following energy bands:
- (i) conduction band;
 - (ii) valence band. (4 marks)
7. (a) (i) State **three** areas of application of bipolar junction transistors .
- (ii) Draw a circuit diagram showing the common collector configuration of a n-p-n transistor. (6 marks)

- (b) A transistor used in a common-emitter amplifier has the data given in table 1. The amplifier is supplied from a $16V_{dc}$ source and has a collector load resistor of $1.5 K\Omega$. The quiescent base current $150 \mu A$.

- (i) Plot the output characteristic curves;
- (ii) Draw the d.c loadline;
- (iii) Determine the Q-point;
- (iv) Obtain the quiescent values of the collector current and, the collector-to-emmitter voltage.

(11 marks)

Table 1

V_{ce} (V)	I_c (mA)		
	$I_b=0 \mu A$	$I_b=150 \mu A$	$I_b=300 \mu A$
2	1.5	4.5	8.0
14	2.0	5.3	9.5

- (c) State the factors that affect the bias stability of transistor amplifiers.

(3 marks)

- (a) Define each of the following with respect to d.c power supplies:

- (i) peak inverse voltage;
- (ii) ripple factor.

(2 marks)

- (b) Show that the d.c voltage from a single-phase full-wave rectifier is given by the expression.

$$V_{dc} = \frac{2V_p}{\pi}$$

Where V_p = peak value of the rectified voltage.

(6 marks)

- (c) Draw a circuit diagram of a half-wave voltage doubler and describe its operation.

(6 marks)

- (d) An electrostatic cathode ray tube (CRT) has a deflection voltage of 200V and a parallel deflecting plate 2cm long. The amount of deflection of the electron beam is 6cm and the velocity of the electron beam is 26.52×10^6 m/s. Determine the:

- (i) deflection sensitivity;
- (ii) deflection factor;
- (iii) transit time of the beam through the deflecting plates.

(6 marks)

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